# DUALSCOPE<sup>®</sup> MPOR DUALSCOPE<sup>®</sup> MPOR-FP

Pocket Instruments with PC-Interface for Convenient and Fast Coating Thickness Measurement on Virtually all Metals





# DUALSCOPE<sup>®</sup> MPOR Models

### Description

		uring instruments measure coating thicknesses e precision that is typical for all Fischer instru	
Instrument properties	<ul> <li>Ideal for onsite applications due to the compact size, the light weight and the robust and durable instrument design</li> <li>Intuitive operation of the menu navigation and graphic display. The display turns automatically, like a smart phone</li> <li>Second display for reading the measurement results directly on the top side of the instrument, e.g., for measuring overhead</li> <li>Different languages are selectable</li> </ul>		
	Generating measurements	<ul> <li>The specimen's shape and permeability have a comparatively low influence on the measurement results</li> <li>Patented conductivity compensation for measurements on non-magnetic substrate materials</li> </ul>	
	<ul> <li>Two special measuring modes in accordance with the measurement regulations IMO PSPC (90/10-Rule) and SSPC-PA2</li> </ul>		
Applications	Steel or iron substrates (Fe)	Nonferrous metal substrates (NFe)	
Examples	<ul> <li>Zinc, chromium, copper, paint, varnish and plastic coatings on steel, iron or cast iron (Fe)</li> </ul>	<ul> <li>Paint, varnish or plastic coatings on alu- minum, copper or brass</li> </ul>	
		<ul> <li>Anodized coatings on aluminum</li> </ul>	
	The instruments are applicable for measurer	ments both on smooth and rough surfaces	
Models			
	<ul> <li>DUALSCOPE MPOR: Probe integrated in the measuring instrument for single-handed operation</li> </ul>		
	<ul> <li>DUALSCOPE MPOR-FP: Probe with cable ( instrument, for measurements on various s</li> </ul>	80 cm; 31.5 ") permanently connected to the specimen shapes	
Evaluation			
Statistics	Display of mean value, standard deviation, MIN, MAX and number of measurements pe block		
PC software	PC software FISCHER DataCenter with the following functionality: Transferring and		
included in delivery	archiving measurement data, comprehensive statistical and graphical evaluations, easy creation and printing of inspection reports		
Measuring Modes			
Standard (Std)	Standard measuring mode for simple, universal coating thickness measurements, all measurement functions are available.		
IMO PSPC 90/10 (90.10)	90/10 rule stored in the instrument for coating thickness measurements according to the requirements of the "Performance Standard for Protective Coatings" of the International Maritime Organization (IMO PSPC).		
SSPC-PA2 (SSPC)	Coating thickness measurement according to the test specification SSPC-PA2 of the Society for Protective Coatings (SSPC).		

#### **Measurement Functions**

Block size	Adjustable between 2 and 20 single readings per block	
Tolerance limits	Adjustable, depending on the selected measuring mode	
Offset value	In the standard mode, the freely adjustable offset value is deducted automatically from the measured value. Thus, one obtains the thickness of the top coating if for instance the interim coating is known.	
Units of measurement	Selectable µm or mils/thou	
Continuous display mode	Measurement in "continuous display mode" for continuous sampling of the surfaces, e.g. in the manufacture of tanks and containers.	
Normalization	Adaptation to the substrate material and the shape of the specimen.	
Calibration	Factory calibration Each individual instrument is factory calibrated at several reference points with the greatest care to ensure the highest possible degree of trueness. Corrective calibration (Adjustment) Adaptation to the substrate material and the shape of the specimen and to a thickness value using a calibration foil	
General Features		
Measuring method	Magnetic induction method (ISO 2178, ASTM D7091, Measurement of non-magnetic coatings on magnetic substrates); Eddy current method (ISO 2360, ASTM D7091, Measurement of non-conductive coatings on non-magnetic substrate metals); Automatic selection of the measuring method corresponding to the substrate material	
Probe	Probe tip radius: 2 mm (78 mils); probe tip material: hard metal	
Data memory	Max. 10,000 individual readings; the contents of the memory is retained even without batteries	
Measuring frequency	More than 70 measurements per minute	
Measurement acquisition	Automatic upon placement of the probe; indication of the measurement with a beep visually with a green lit LED	
Display limit value violation	Acoustically through 2 short beeps and visually with a red lit LED	
Display	<ul> <li>Graphic display with an automatically turning display in order to read the measuremen results in many different instrument positions</li> <li>LCD display on the top side of the instrument, e.g., for measurement overhead</li> </ul>	
Languages	Many different display languages are selectable: German, English and several other European and Asian languages	
USB port	2.0 compatible, for connecting a PC	
Data transfer	Single readings, mean values, group separator	
Admissible ambient temperature range during operation	0 +40 °C (32 +104 °F)	
Weight (incl. batteries)	MPOR: 137 g (4.8 oz) MPOR-FP: 184 g (6.5 oz)	
Power supply	Batteries, LR6, AA, 1.5 V	

## DUALSCOPE<sup>®</sup> MPOR Models

#### **Dimensions**

Instrument	Width: 64 mm (2.52 "); Depth: 28 mm (1.10 "); Height: 85 mm (3.35 ")		
Probe of instrument MPOR-FP			
Measurement Range	Steel or iron substrates (Fe)	Nonferrous metal substrates (NFe)	
	0 2000 µm (78 mils)	0 2000 µm (78 mils)	
Trueness	Steel or iron substrates (Fe)	Nonferrous metal substrates (NFe)	
based on Fischer Standards	0 75 µm: ≤ 1.5 µm 75 1000 µm: ≤ 2 % of reading 1000 2000 µm: ≤ 3 % of reading	0 50 µm: ≤ 1 µm 50 1000 µm: ≤ 2 % of reading 1000 2000 µm: ≤ 3 % of reading	
	0 2.9 mils: ≤ 0.06 mils 2.9 39 mils: ≤ 2 % of reading 39 78 mils: ≤ 3 % of reading	0 2 mils: ≤ 0.039 mils 2 39 mils: ≤ 2 % of reading 39 78 mils: ≤ 3 % of reading	
Repeatability Precision	Steel or iron substrates (Fe)	Nonferrous metal substrates (NFe)	
based on Fischer Standards	0 50 µm: ≤ 0.25 µm 50 2000 µm: ≤ 0.5 % of reading	0 100 μm: ≤ 0.5 μm 100 2000 μm: ≤ 0.5 % of reading	
	0 2 mils: ≤ 0.0098 mils 2 78 mils: ≤ 0.5 % of reading	0 3.9 mils: ≤ 0.0195 mils 3.9 78 mils: ≤ 0.5 % of reading	
Ordering Data			
605-097	DUALSCOPE MPOR, probe integrated in the measuring instrument		
605-114	DUALSCOPE MPOR-FP, probe with cable (80 cm; 31.5 ") permanently connected to th instrument		
Scope of Supply			
	ISO/NF for testing purposes; calibration	er; lanyard; 2 batteries; metal plates NF/FE of foil; operator's manual; manufacturer's certif ivers, software program FISCHER DataCenter	

convenient evaluating, documenting and archiving of the measurement data, software pro-

-rischer

gram PC-Datex for exporting the measurement data to an Excel spreadsheet

DUALSCOPE<sup>®</sup> is a registered trademark of Helmut Fischer GmbH Institut für Elektronik und Messtechnik in Germany and in other coun-

tries.

www.helmut-fischer.com